

Search Notes

Application/Control No.

10/069,792

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under
Reexamination

BUERCK ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	220.01 221.01	7/13/2006	QN
370	395.2 395.21 352	7/13/06	QN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched: East, USPGPub, USPAT	7/13/06	QN
Inventor searched through PALLM database	7/13/06	QN